

UTC UNISONIC TECHNOLOGIES CO., LTD

1N60-MS **Preliminary Power MOSFET**

1.0A, 600V N-CHANNEL POWER MOSFET

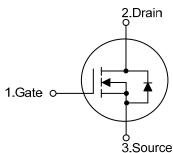
DESCRIPTION

The UTC 1N60-MS is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)} \le 14 \Omega$ @ $V_{GS}=10V$, $I_D=0.5A$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

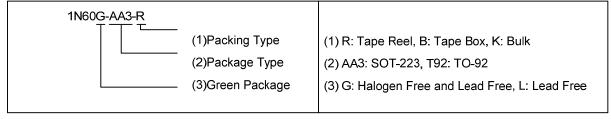


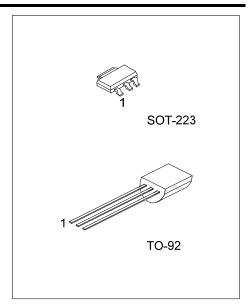


ORDERING INFORMATION

Ordering Number		Dookooo	Pin Assignment			Daakina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
1N60L-AA3-R	1N60G-AA3-R	SOT-223	G	D	S	Tape Reel	
1N60L-T92-B	1N60G-T92-B	TO-92	G	D	S	Tape Box	
1N60L-T92-K	1N60G-T92-K	TO-92	G	D	S	Bulk	

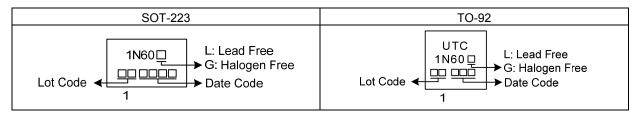
S: Source Note: Pin Assignment: G: Gate D: Drain





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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	600	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Continuous Drain Current		I _D	1	Α	
Pulsed Drain Current (Note 2)		I _{DM}	2	Α	
Avalanche Energy (Note 3)	Single Pulsed	E _{AS}	21	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.8	V/ns	
Power Dissipation	SOT-223		8	W	
	TO-92	P _D	1.5	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
 - 3. L=30mH, I_{AS}=1.2A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C
 - 4. $I_{SD} \le 1.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	SOT-223	0	150	°C/W
	TO-92	θ_{JA}	140	°C/W
Junction to Case	SOT-223	0	15.6	°C/W
	TO-92	θ _{JC}	80	°C/W

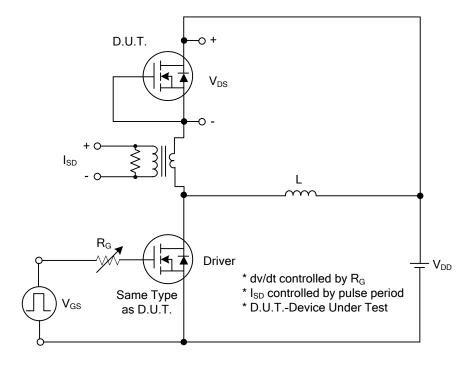
■ ELECTRICAL CHARACTERISTICS (T_C =25°C, unless otherwise specified)

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PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} =0V, I_D =250 μ A	600			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =600V, V _{GS} =0V			10	μΑ
Gate-Source Leakage Current	Forward	I _{GSS}	V_{GS} =30V, V_{DS} =0V			100	nΑ
	Reverse		V_{GS} =-30V, V_{DS} =0V			-100	nΑ
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =0.5A			14	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance Output Capacitance		C _{ISS}	V _{DS} =25V, V _{GS} =0V, f =1MHz		86		pF
		Coss			16		pF
Reverse Transfer Capacitance		C_{RSS}			2		pF
SWITCHING CHARACTERISTIC	S						
Total Gate Charge		Q_{G}	V 400V V 40V L 4.0A		8		nC
Gate-Source Charge		Q_GS	V_{DS} =480V, V_{GS} =10V, I_{D} =1.0A, I_{G} =1mA (Note 1, 2)		3.5		nC
Gate-Drain Charge		Q_GD	IG=IIIA (Note 1, 2)		1.4		nC
Turn-On Delay Time		t _{D (ON)}			2.5		ns
Turn-On Rise Time		t_R	$V_{DD} = 100V, V_{GS} = 10V, I_D = 1.0A,$		16		ns
Turn-Off Delay Time		$t_{D(OFF)}$	R _G =25Ω (Note 1, 2)		12		ns
Turn-Off Fall Time		t _F			36		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	cs					
Maximum Continuous Drain-Source Diode		Is				1	^
Forward Current						1	Α
Maximum Pulsed Drain-Source Diode		I _{SD}				2	Α
Forward Current							^
Drain-Source Diode Forward Voltage		V_{SD}	I _S =1.0A, V _{GS} =0V			1.4	V
Reverse Recovery Time		t _{rr}	I _F =1.0A, V _{DD} =100V		170		ns
Reverse Recovery Charge		Q_{rr}	di/dt = 100A/µs		1.2		μC

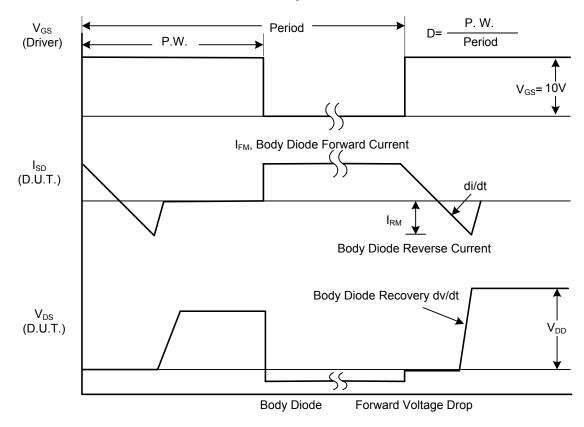
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle≤2%.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

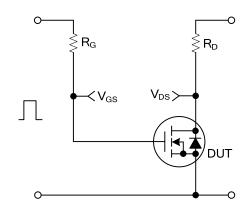


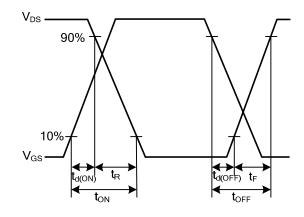
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

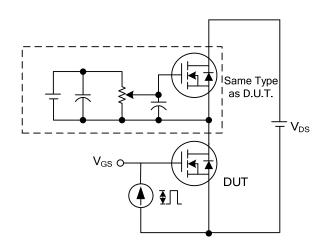
TEST CIRCUITS AND WAVEFORMS

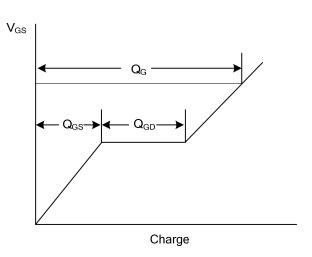




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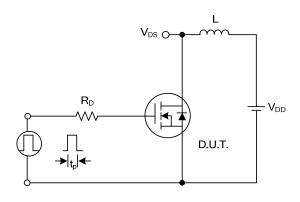
Switching Waveforms

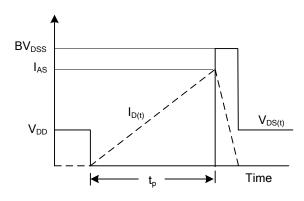




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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